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Form PTO 1449 (Modified)		U.S. DEPARTMENT PATENT AND TRAD	OF COMMERCE EMARK OFFICE	ATTY DOCKET NO. 241856US2	SERIAL NO. 10/647,291		
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	AP	WO 02/05285	1-17-02	WIPO			X
	AQ	2000-353226	12-19-00	Japan (w/English Abstract)			×
	AR	2002-041341	2-8-02	Japan (w/English Abstract)			×
	AS	07-302175	11-14-95	Japan (w/English Abstract)			×
4	AT	06-095979	4-8-94	Japan (w/English Abstract)			×
	AU	2000-353226	12-19-00	Japan (w/English Abstract)			×
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